



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Alan G. Yates

PATENT APPLICATION

Serial No.: 10/764,807

Group Art Unit: 2829

Filed: January 26, 2004

Examiner: M.N. Tang

For: INTEGRATED CIRCUIT TEST DEVICE (as amended)

Amendment

Hon. Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

Sir or Madam:

In response to the Office action mailed March 7, 2005, the applicant respectfully requests reconsideration in light of the following amendments and remarks.

In the title:

Please change the title to read - - INTEGRATED
CIRCUIT TEST DEVICE - -.